

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/587,807 MIYATA ET AL.	
		Examiner	Art Unit	Page 1 of 1 MARK L. SHEVIN 1793

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	N	JP 2002-105604	04-2002	Japan	Kimura et al.	C22C 38/00
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#### NON-PATENT DOCUMENTS

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